09/876980

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE

WIEEE

Publications/Services Standards Conferences Careers/Jobs Welcome **United States Patent and Trademark Office Quick Links** » Se. FAQ Terms IEEE Peer Review Help Welcome to IEEE Xplore® O- Home Your search matched 8 of 1049776 documents. O- What Can A maximum of 500 results are displayed, 15 to a page, sorted by Relevance I Access? **Descending** order. ()- Log-out **Refine This Search: Tables of Contents** You may refine your search by editing the current search expression or enterior O- Journals new one in the text box. & Magazines Search (low discrepancy) <near/3> (curve <or> scan* <or> ;)- Conference ☐ Check to search within this result set **Proceedings** O- Standards **Results Key: JNL** = Journal or Magazine **CNF** = Conference **STD** = Standard Search O- By Author O- Basic 1 Deterministic design for neural network learning: an approach base discrepancy ()- Advanced Cervellera, C.; Muselli, M.; **Member Services** Neural Networks, IEEE Transactions on , Volume: 15 , Issue: 3 , May 2004 Pages: 533 - 544 O Join IEEE - Establish IEEE [Abstract] [PDF Full-Text (360 KB)] **IEEE JNL** Web Account 2 Discrepancy as a quality measure for avoiding classification bias O- Access the Iwata, K.; Ishii, N.; **IEEE Member Digital Library** Intelligent Control, 2002. Proceedings of the 2002 IEEE International Sympos on , 27-30 Oct. 2002 **IEEE Enterprise** Pages:532 - 537 O- Access the **IEEE Enterprise** [PDF Full-Text (580 KB)] File Cabinet 3 Quasi-Monte Carlo methods in cash flow testing simulations Print Format Hilgers, M.G.; Simulation Conference Proceedings, 2000. Winter, Volume: 1, 10-13 Dec. 2 Pages:517 - 526 vol.1 [PDF Full-Text (1176 KB)] [Abstract] **IEEE CNF** 4 On the use of low-discrepancy sequences in non-holonomic motion planning Sanchez, A.; Zapata, R.; Lanzoni, C.;

Conference on , Volume: 3 , 14-19 Sept. 2003

Pages: 3764 - 3769 vol. 3

Robotics and Automation, 2003. Proceedings. ICRA '03. IEEE International

[Abstract] [PDF Full-Text (478 KB)] IEEE CNF

5 Neural network training and stochastic global optimization *Jordanov, I.*;

Neural Information Processing, 2002. ICONIP '02. Proceedings of the 9th International Conference on , Volume: 1 , 18-22 Nov. 2002 Pages:488 - 492 vol.1

[Abstract] [PDF Full-Text (567 KB)] IEEE CNF

6 Parallel and distributed computing issues in pricing financial deriva through quasi Monte Carlo

Srinivasan, A.;

Parallel and Distributed Processing Symposium., Proceedings International, If 2002, Abstracts and CD-ROM , 15-19 April 2002 Pages:14 - 19

[Abstract] [PDF Full-Text (268 KB)] IEEE CNF

7 Efficiency improvement by lattice rules for pricing Asian options Lemieux, C.; L'Ecuyer, P.;

Simulation Conference Proceedings, 1998. Winter , Volume: 1 , 13-16 Dec. 1 Pages: 579 - 585 vol.1

[Abstract] [PDF Full-Text (540 KB)] IEEE CNF

8 Incremental low-discrepancy lattice methods for motion planning Lindemann, S.R.; LaValle, S.M.;

Robotics and Automation, 2003. Proceedings. ICRA '03. IEEE International Conference on , Volume: 3 , 14-19 Sept. 2003 - Pages: 2920 - 2927 vol.3

[Abstract] [PDF Full-Text (628 KB)] IEEE CNF

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help | FAQ | Terms | Back to Top

Copyright © 2004 IEEE - All rights reserved

IEEE HOME I SEARCHIEEE I SHOP I WEB ACCOUNT I CONTACT IEEE

Membership Publications/Services Standards Conferences Careers/Jobs



IEEE /	(plore® Unit	Welcome ed States Patent and Trademark Office	
Help FAQ Terms IEE	Peer Review Quick Links	<u> -</u>	» Se
Welcome to IEEE Xplores - Home - What Can I Access? - Log-out Tables of Contents - Journals & Magazines - Conference Proceedings - Standards	Your search matched 0 of A maximum of 500 resunding order. Refine This Search:	can* Search	
Search - By Author - Basic - Advanced	JNL = Journal or Magaz Results: No documents matche	ine CNF = Conference STD = Standar ed your query.	d
Member Services - Join IEEE - Establish IEEE Web Account - Access the			
IEEE Member Digital Library IEEE Enterprise Access the IEEE Enterprise File Cabinet			
Print Format			

Publications | Help | FAQ| Terms | Back to Top Copyright © 2004 IEEE - All rights reserved

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online

IEEE HOME | SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE



Membership Publications/Services Standards Conferences Careers/Jobs			
IEEE >	RELEASE 1.8		
Help FAQ Terms IEEI	E Peer Review Quick Links Se.		
Welcome to IEEE Xplore® - Home - What Can I Access? - Log-out Tables of Contents - Journals & Magazines - Conference Proceedings - Standards	Your search matched 7 of 1049776 documents. A maximum of 500 results are displayed, 15 to a page, sorted by Relevance Descending order. Refine This Search: You may refine your search by editing the current search expression or enterinew one in the text box. (halton <or></or>		
Search	Results Key: JNL = Journal or Magazine CNF = Conference STD = Standard		
O- By Author O- Basic O- Advanced Member Services O- Join IEEE O- Establish IEEE Web Account	1 Characterization of temperature-dependent biophysical properties during laser mediated cartilage reshaping Wong, B.J.F.; Milner, T.E.; Kim, H.K.; Telenkov, S.A.; Chew, C.F.; Sobol, E.N Nelson, J.S.; Selected Topics in Quantum Electronics, IEEE Journal of, Volume: 5, Issue: 4, July-Aug. 1999 Pages: 1095 - 1102		
O- Access the	[Abstract] [PDF Full-Text (296 KB)] IEEE JNL		
IEEE Member Digital Library IEEE Enterprise - Access the IEEE Enterprise File Cabinet Print Format	2 Hardware description language modeling of an electrostatically actibi-axial micromirror Parrain, F.; Megherbi, S.; Raynaud, G.; Mathias, H.; Gilles, JP.; Bosseboeuf, Schropfer, G.; Faure, N.; Cusin, P.; Thermal and Mechanical Simulation and Experiments in Microelectronics and Microsystems, 2004. EuroSimE 2004. Proceedings of the 5th International Conference on , 10-12 May 2004 Pages:393 - 397		
	[Abstract] [PDF Full-Text (660 KB)] IEEE CNF		
	Thermomechanical behavior of ceramic ball grid array based on experiments and FEM simulations Deletage, JY.; Fenech, A.; Bechou, L.; Ousten, Y.; Danto, Y.; Salagoity, M.; Faure, C.; Rao, S.; Electronics Manufacturing Technology Symposium, 1996., Nineteenth IEEE/CPMT, 14-16 Oct. 1996 Pages:91 - 98 [Abstract] [PDF Full-Text (956 KB)] IEEE CNF		

4 **IS-FPGA**: a new symmetric FPGA architecture with implicit scan Renovell, M.; Faure, P.; Portal, J.M.; Figueras, J.; Zorian, Y.; Test Conference, 2001. Proceedings. International, 30 Oct.-1 Nov. 2001 Pages: 924 - 931

[Abstract] [PDF Full-Text (620 KB)] IEEE CNF

5 Evaluation of conductive adhesives for industrial SMT assemblies Perichaud, M.G.; Deletage, J.Y.; Fremont, H.; Danto, Y.; Faure, C.; Salagoity, Electronics Manufacturing Technology Symposium, 1998. Twenty-Third IEEE/CPMT, 19-21 Oct. 1998 Pages: 377 - 385

[Abstract] [PDF Full-Text (860 KB)] IEEE CNF

6 Sintering of lead titanate and titano-zirconate sol-gel thin films
Gaucher, P.; Lequien, S.; Ganne, J.P.; Faure, S.; Barboux, P.;
Applications of Ferroelectrics, 1990., IEEE 7th International Symposium on , (
June 1990
Pages: 267 - 270

[Abstract] [PDF Full-Text (216 KB)] IEEE CNF

7 Anodic dissolution of InP

Faur, M.; Goradia, M.; Bailey, S.; Indium Phosphide and Related Materials, 1990. Second International Confere, 23-25 April 1990 Pages: 242 - 248

[Abstract] [PDF Full-Text (536 KB)] IEEE CNF

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account |
New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online
Publications | Help. | FAQ | Terms | Back to Top

Copyright © 2004 IEEE — All rights reserved